Application/Control No.	Applicant(s)/Patent under Reexamination
09/891,017	IKEDA ET AL.
Examiner	Art Unit
LUONG T. NGUYEN	2622

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPAT; US-PGPUB; JPO; EPO; DERWENT) see search history printout	2/3/2006	LN		
348/222.1; 382/162 (text search only, see search history printout)	9/1/2006	LN		
EAST (USPAT; US-PGPUB; JPO; EPO; DERWENT; IBM_TDB) see search history printout	9/1/2006	LN		